

測試報告 Test Report

號碼(No.): CE/2008/81406

日期(Date): 2008/08/13

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FULTEC SEMICONDUCTOR INC


2029 STIERLIN COURT, SUITE 120 MOUNTAIN VIEW, CA 94043



以下測試樣品係由客戶送樣，且由客戶聲稱並經客戶確認如下 (The following samples was/were submitted and identified by/on behalf of the client as):

樣品名稱(Sample Description) : FULTEC TBU
樣品型號(Style/Item No.) : PX50-GXXX
收件日期(Sample Receiving Date) : 2008/8/6
測試期間(Testing Period) : 2008/8/6 TO 2008/8/13

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測試需求(Test Requested) : 參照 RoHS 2002/95/EC 及其修定指令要求. (In accordance with the RoHS Directive 2002/95/EC, and its amendment directives).
測試方法(Test Method) : 參考 IEC 62321/2nd CDV (111/95/CDV) 方法檢測. (With reference to IEC 62321/2nd CDV (111/95/CDV). Procedures for the Determination of Levels of Regulated Substances in Electrotechnical Products).
(1) 用感應耦合電漿原子發射光譜儀檢測鎘含量. / Determination of Cadmium by ICP-AES.
(2) 用感應耦合電漿原子發射光譜儀檢測鉛含量. / Determination of Lead by ICP-AES.
(3) 用感應耦合電漿原子發射光譜儀檢測汞含量. / Determination of Mercury by ICP-AES.
(4) 針對非金屬材質之樣品，用UV-VIS檢測六價鉻含量. / Determination of Hexavalent Chromium for non-metallic samples by UV/Vis Spectrometry.
(5) 以氣相層析儀/質譜儀檢測多溴聯苯和多溴聯苯醚含量. / Determination of PBB and PBDE by GC/MS.
測試結果(Test Results) : 請見下一頁 (Please refer to next pages).


Chenyu Kung / Operation Manager
Signed for and on behalf of
SGS TAIWAN LTD.
Chemical Laboratory – Taipei

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測試結果(Test Results) 單位(Unit): mg/kg

測試項目 (Test Items)	測試方法 Method (Refer to)	結果 (Result)	方法偵測 極限值 (MDL)
		No.1	
鎘 / Cadmium (Cd)	(1)	n.d.	2
鉛 / Lead (Pb)	(2)	n.d.	2
汞 / Mercury (Hg)	(3)	n.d.	2
六價鉻 / Hexavalent Chromium Cr(VI) by alkaline extraction	(4)	n.d.	2
多溴聯苯總和 / Sum of PBBs	(5)	n.d.	-
一溴聯苯 / Monobromobiphenyl		n.d.	5
二溴聯苯 / Dibromobiphenyl		n.d.	5
三溴聯苯 / Tribromobiphenyl		n.d.	5
四溴聯苯 / Tetrabromobiphenyl		n.d.	5
五溴聯苯 / Pentabromobiphenyl		n.d.	5
六溴聯苯 / Hexabromobiphenyl		n.d.	5
七溴聯苯 / Heptabromobiphenyl		n.d.	5
八溴聯苯 / Octabromobiphenyl		n.d.	5
九溴聯苯 / Nonabromobiphenyl		n.d.	5
十溴聯苯 / Decabromobiphenyl		n.d.	5
多溴聯苯醚總和 / Sum of PBDEs		n.d.	-
一溴聯苯醚 / Monobromodiphenyl ether		n.d.	5
二溴聯苯醚 / Dibromodiphenyl ether		n.d.	5
三溴聯苯醚 / Tribromodiphenyl ether		n.d.	5
四溴聯苯醚 / Tetrabromodiphenyl ether		n.d.	5
五溴聯苯醚 / Pentabromodiphenyl ether		n.d.	5
六溴聯苯醚 / Hexabromodiphenyl ether		n.d.	5
七溴聯苯醚 / Heptabromodiphenyl ether		n.d.	5
八溴聯苯醚 / Octabromodiphenyl ether		n.d.	5
九溴聯苯醚 / Nonabromodiphenyl ether		n.d.	5
十溴聯苯醚 / Decabromodiphenyl ether		n.d.	5

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測試部位描述 (TEST PART DESCRIPTION):

NO.1 : 整體混測 (PX-50-GXXX) (MIXED ALL PARTS)

備註(Note):

1. mg/kg = ppm
2. n.d. = Not Detected (未檢出)
3. MDL = Method Detection Limit (方法偵測極限值)
4. "-" = Not Regulated (無規格值)
5. 樣品的測試是基於申請人要求混合測試，報告中的混合測試結果不代表其中個別單一材質的含量。
(The samples was/were analyzed on behalf of the applicant as mixing sample in one testing.
The above results was/were only given as the informality value).

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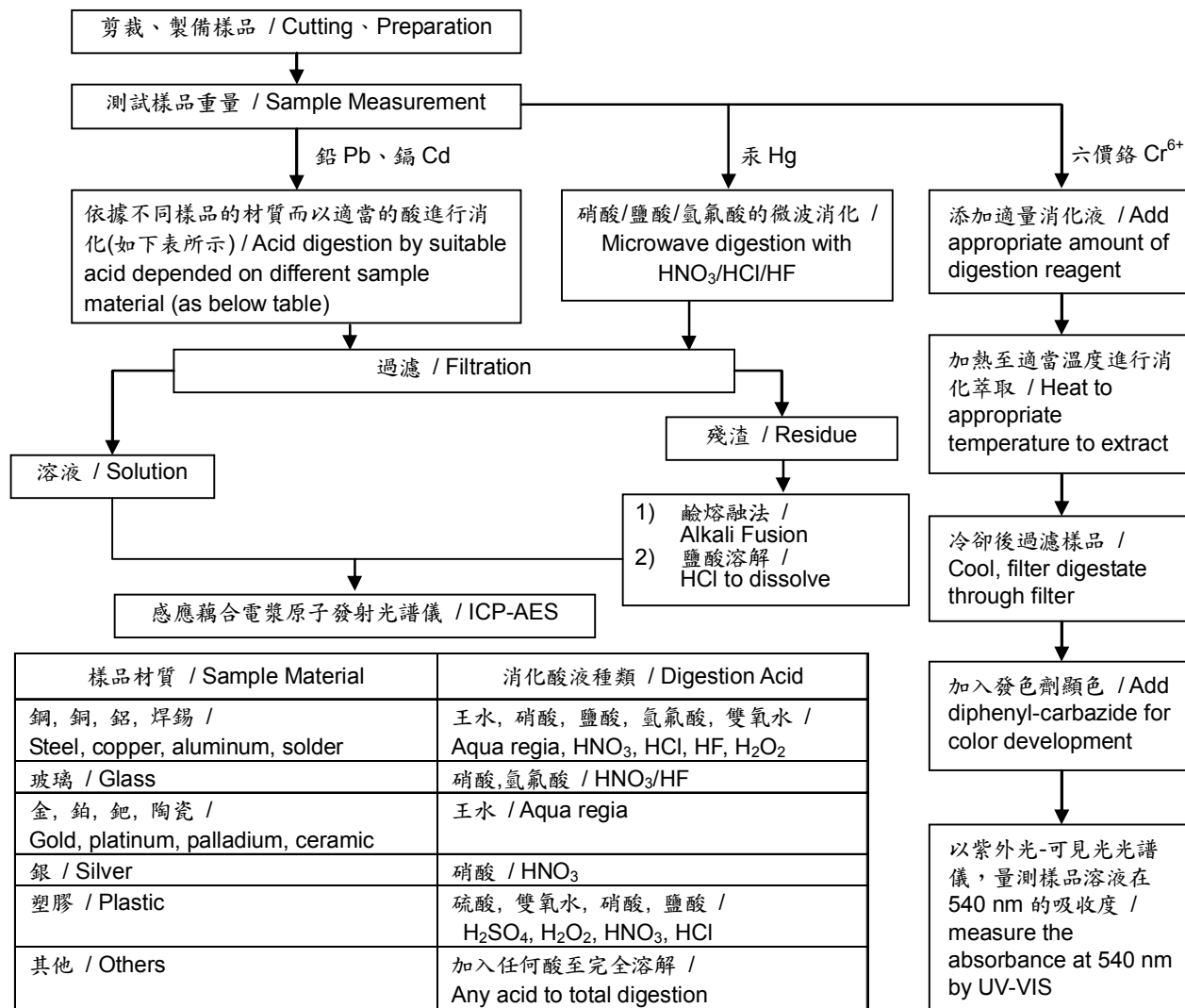
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- 1) 根據以下的流程圖之條件，樣品已完全溶解。(六價鉻測試方法除外) / These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr⁶⁺ test method excluded)
- 2) 測試人員：楊登偉 / Name of the person who made measurement: Climbgreat Yang
- 3) 測試負責人：張啓興 / Name of the person in charge of measurement: Troy Chang



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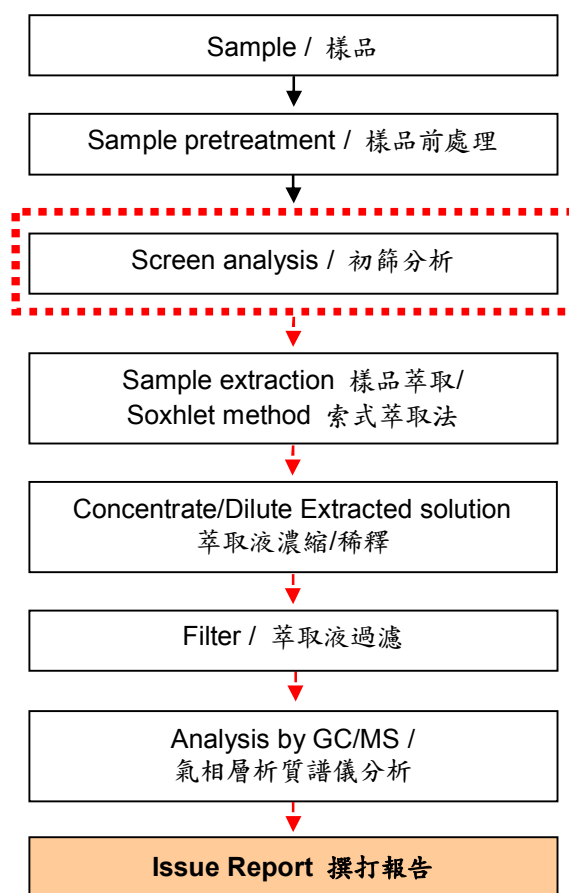
多溴聯苯/多溴聯苯醚分析流程圖 / PBB/PBDE analytical FLOW CHART

- 1) 測試人員: 翁賜彬 / Name of the person who made measurement: Roman Wong
2) 測試負責人: 陳新智 / Name of the person in charge of measurement: Shinjyh Chen

初次測試程序 / First testing process —————>

選擇性篩檢程序 / Optional screen process>

確認程序 / Confirmation process - . - >



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** 報告結尾 **

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